

Asymmetric Dual N-Channel 30-V (D-S) MOSFET

Key Features:

- Low $r_{DS(on)}$ trench technology
- Low thermal impedance
- Fast switching speed

Typical Applications:

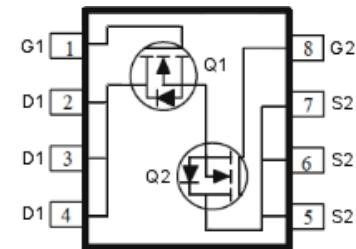
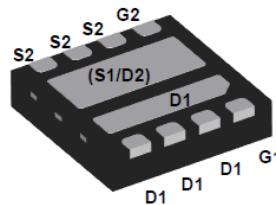
- DC/DC Conversion



RoHS
COMPLIANT
HALOGEN
FREE

PRODUCT SUMMARY		
V_{DS} (V)	$r_{DS(on)}$ (mΩ)	I_D (A)
Q1 20	28 @ $V_{GS} = 5V$	7.7
Q2 30	16 @ $V_{GS} = 5V$	10.2

DFN3X3-8L



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ UNLESS OTHERWISE NOTED)						
Parameter		Symbol	Q1 Limit	Q2 Limit	Units	
Drain-Source Voltage	$T_A=25^\circ C$	V_{DS}	20	30	V	
Gate-Source Voltage		V_{GS}	± 8	± 20		
Continuous Drain Current ^a		I_D	7.7	10.2	A	
$T_A=70^\circ C$			5.6	7.4		
Pulsed Drain Current ^b		I_{DM}	30	40		
Continuous Source Current (Diode Conduction) ^a		I_S	3	3.8		
Power Dissipation ^a	$T_A=25^\circ C$	P_D	2.5	2.5	W	
$T_A=70^\circ C$			1.3	1.3		
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to 150		°C	

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Maximum	Units
Maximum Junction-to-Ambient ^a	$t \leq 10 \text{ sec}$	$R_{\theta JA}$	83	°C/W
	Steady State		120	

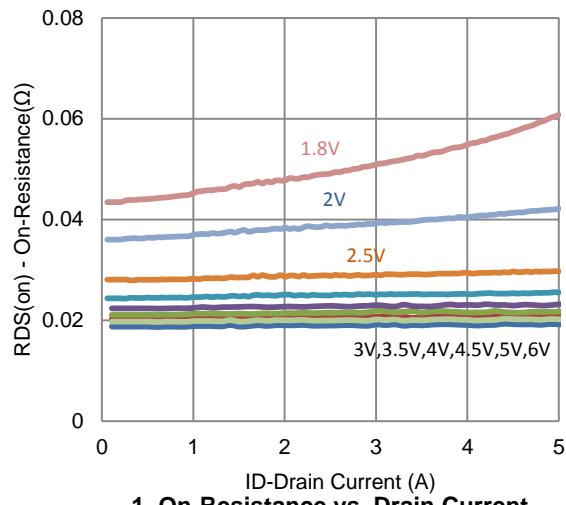
Notes

- Surface Mounted on 1" x 1" FR4 Board.
- Pulse width limited by maximum junction temperature

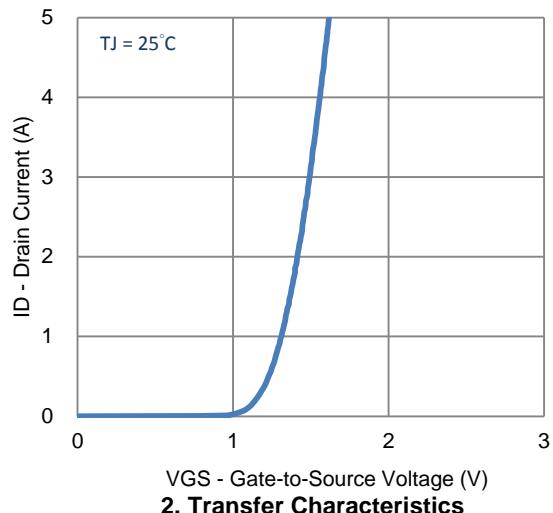
Electrical Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$ (Q1)	0.4			V
		$V_{DS} = V_{GS}, I_D = 250 \mu A$ (Q2)	1			V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 8 V$ (Q1)			± 100	nA
		$V_{DS} = 0 V, V_{GS} = \pm 20 V$ (Q2)			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 16 V, V_{GS} = 0 V$ (Q1)			1	uA
		$V_{DS} = 24 V, V_{GS} = 0 V$ (Q2)			1	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} = 5 V, V_{GS} = 4.5 V$ (Q1)	10			A
		$V_{DS} = 5 V, V_{GS} = 10 V$ (Q2)	15			A
Drain-Source On-Resistance ^a	$r_{DS(on)}$	$V_{GS} = 5 V, I_D = 6.2 A$ (Q1)			28	mΩ
		$V_{GS} = 5 V, I_D = 8.2 A$ (Q2)			16	mΩ
Forward Transconductance ^a	g_{fs}	$V_{DS} = 15 V, I_D = 6.2 A$ (Q1)		7		S
		$V_{DS} = 15 V, I_D = 8.2 A$ (Q2)		13		S
Diode Forward Voltage ^a	V_{SD}	$I_S = 1.5 A, V_{GS} = 0 V$ (Q1)		0.74		V
		$I_S = 1.9 A, V_{GS} = 0 V$ (Q2)		0.77		V
Dynamic ^b						
Total Gate Charge	Q_g	Q1 $V_{DS} = 10 V, V_{GS} = 4.5 V, I_D = 6.2 A$		7		nC
Gate-Source Charge	Q_{gs}			1.1		
Gate-Drain Charge	Q_{gd}			2.3		
Turn-On Delay Time	$t_{d(on)}$	Q1 $V_{DD} = 10 V, R_L = 2.9 \Omega, I_D = 6.2 A,$ $V_{GEN} = 4.5 V, R_{GEN} = 6 \Omega$		10		ns
Rise Time	t_r			23		
Turn-Off Delay Time	$t_{d(off)}$			36		
Fall Time	t_f			16		
Input Capacitance	C_{iss}	Q1 $V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz$		439		pF
Output Capacitance	C_{oss}			78		
Reverse Transfer Capacitance	C_{rss}			68		
Total Gate Charge	Q_g	Q2 $V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 8.2 A$		11		nC
Gate-Source Charge	Q_{gs}			5.0		
Gate-Drain Charge	Q_{gd}			3.6		
Turn-On Delay Time	$t_{d(on)}$	Q2 $V_{DD} = 15 V, R_L = 1.8 \Omega, I_D = 8.2 A,$ $V_{GEN} = 10 V, R_{GEN} = 6 \Omega$		7		ns
Rise Time	t_r			6		
Turn-Off Delay Time	$t_{d(off)}$			30		
Fall Time	t_f			9		
Input Capacitance	C_{iss}	Q2 $V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz$		1379		pF
Output Capacitance	C_{oss}			156		
Reverse Transfer Capacitance	C_{rss}			116		

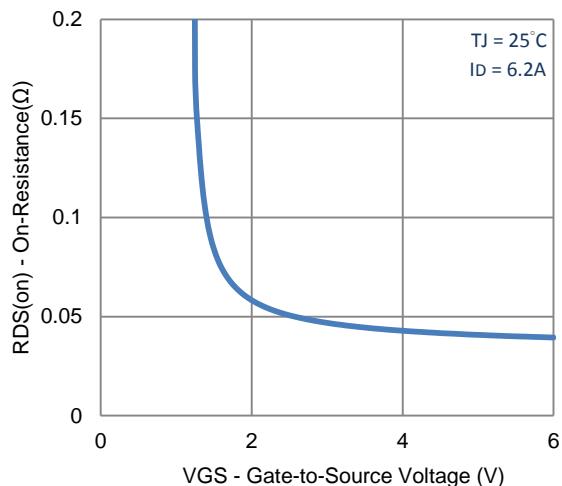
Typical Electrical Characteristics - Q1



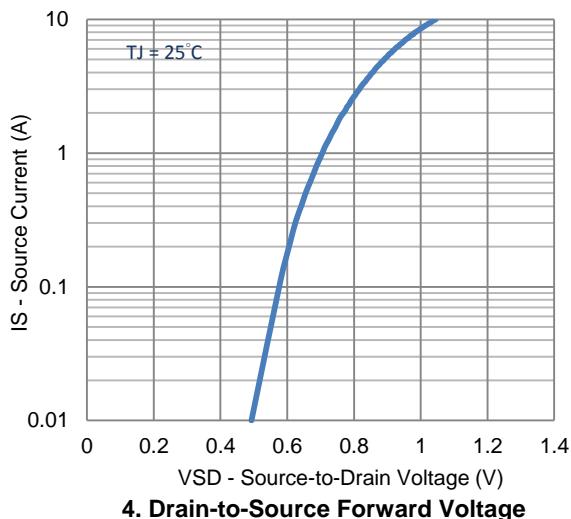
1. On-Resistance vs. Drain Current



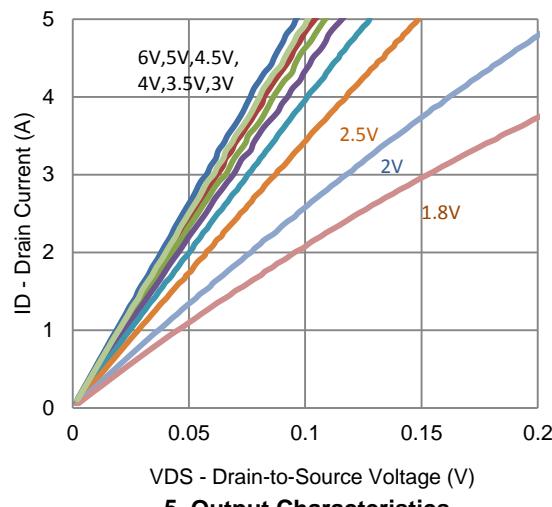
2. Transfer Characteristics



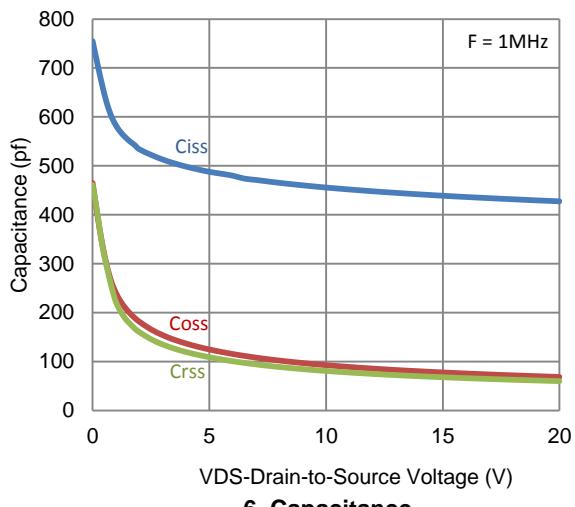
3. On-Resistance vs. Gate-to-Source Voltage



4. Drain-to-Source Forward Voltage

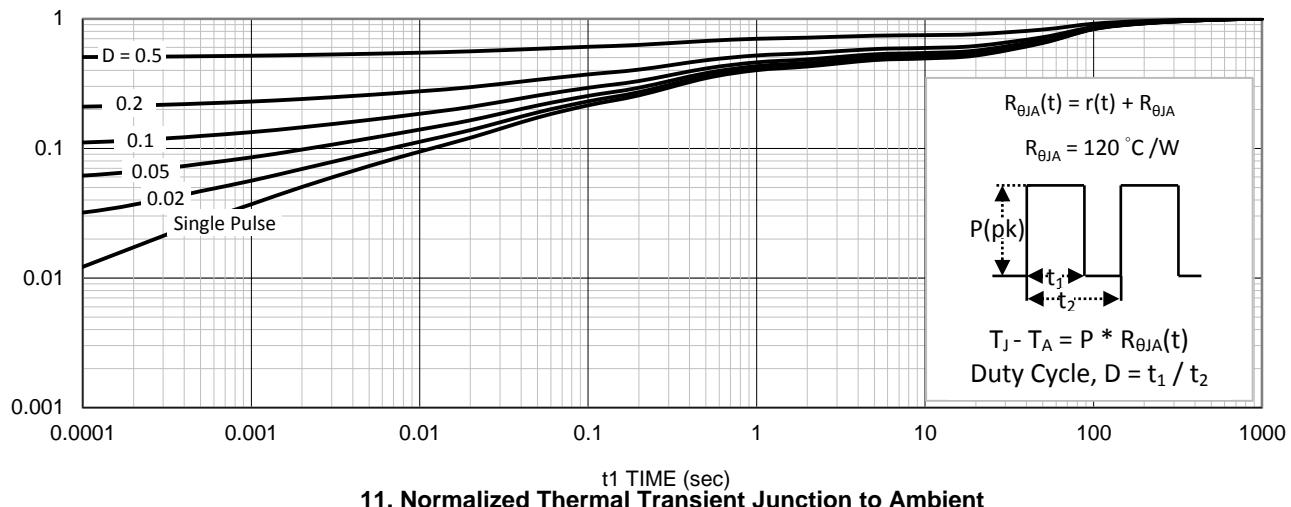
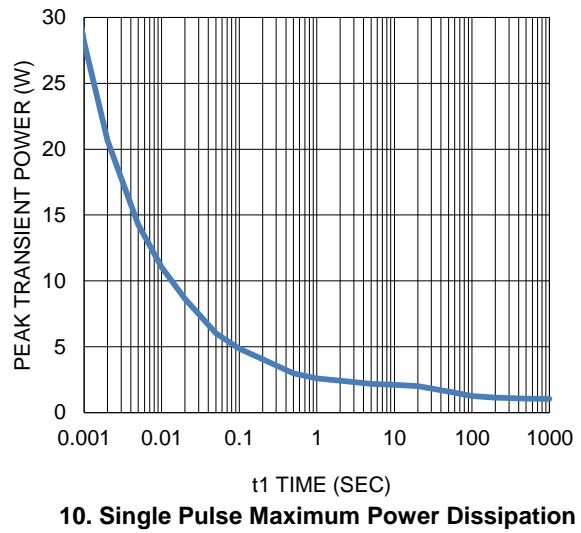
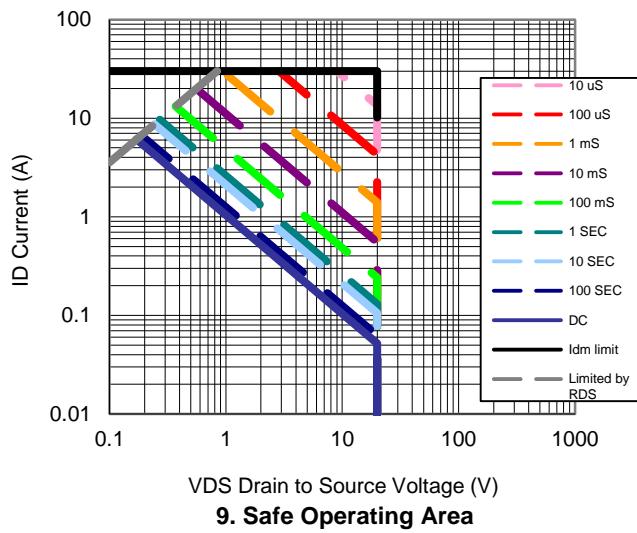
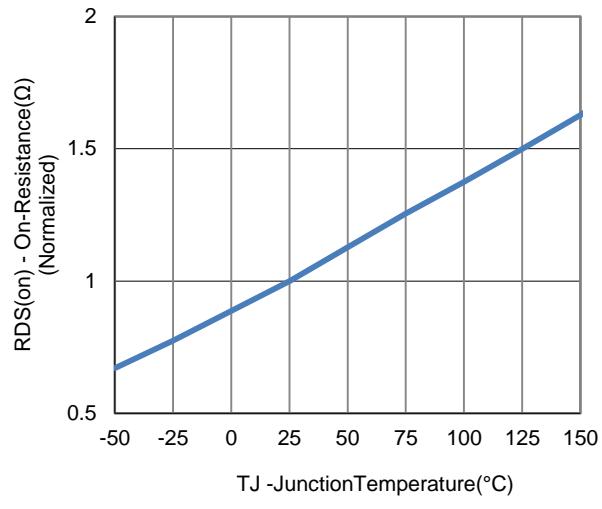
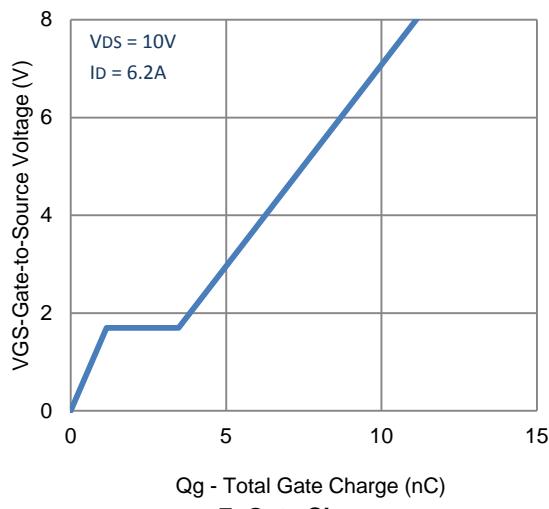


5. Output Characteristics

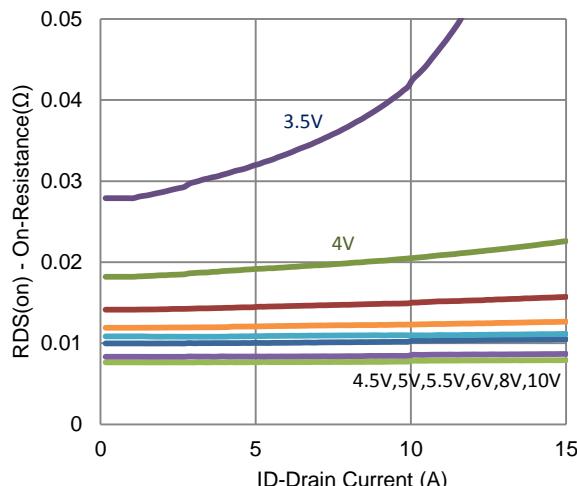


6. Capacitance

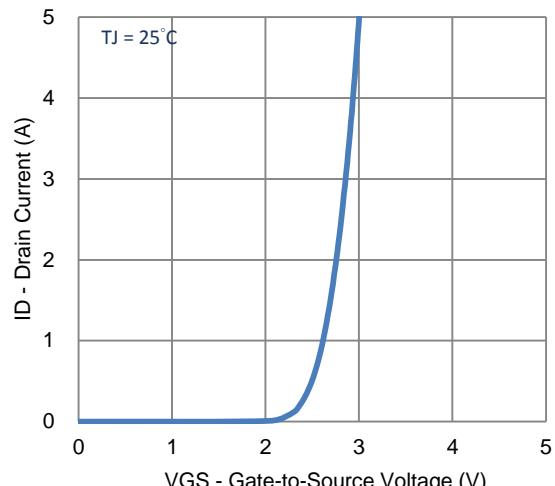
Typical Electrical Characteristics - Q1



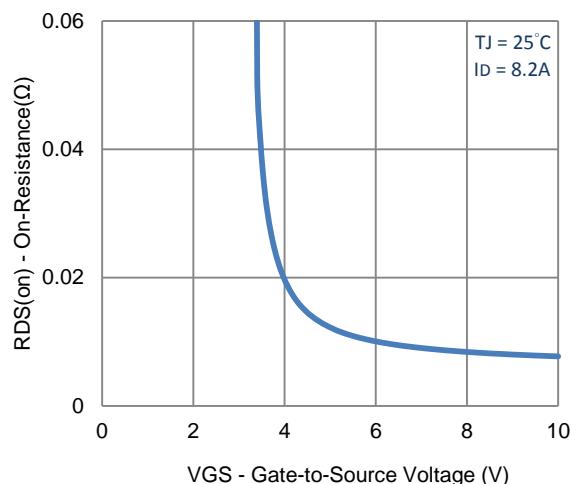
Typical Electrical Characteristics - Q2



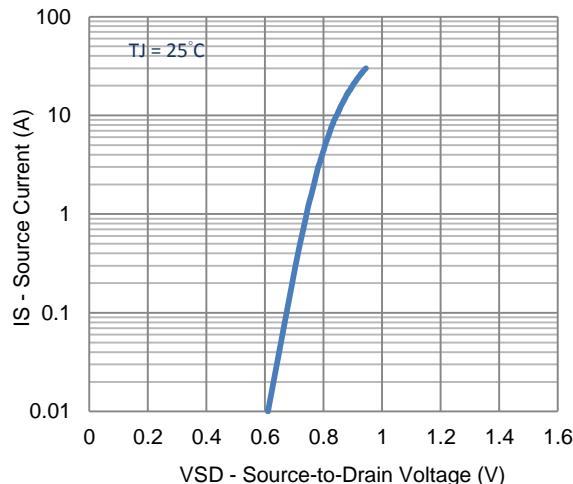
1. On-Resistance vs. Drain Current



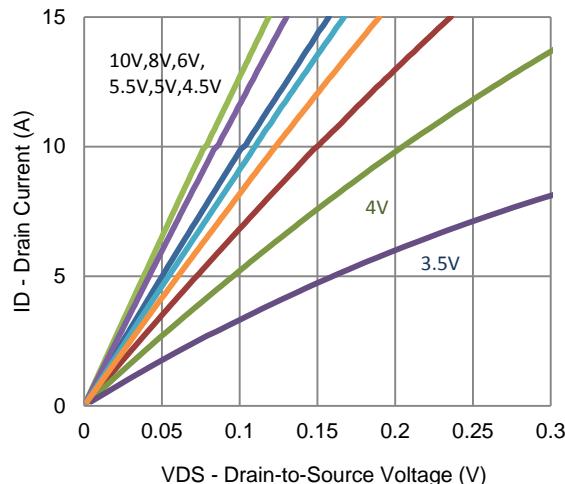
2. Transfer Characteristics



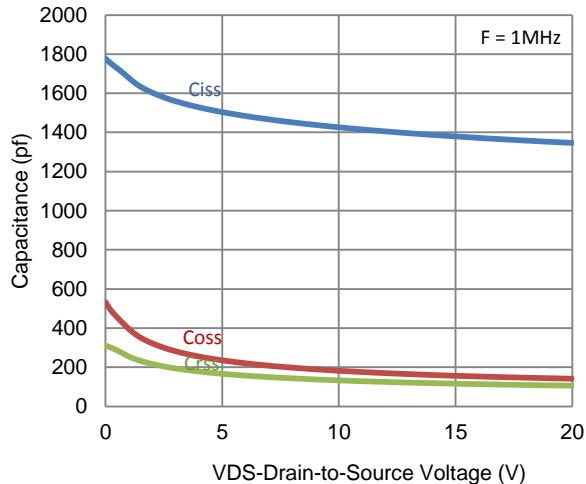
3. On-Resistance vs. Gate-to-Source Voltage



4. Drain-to-Source Forward Voltage

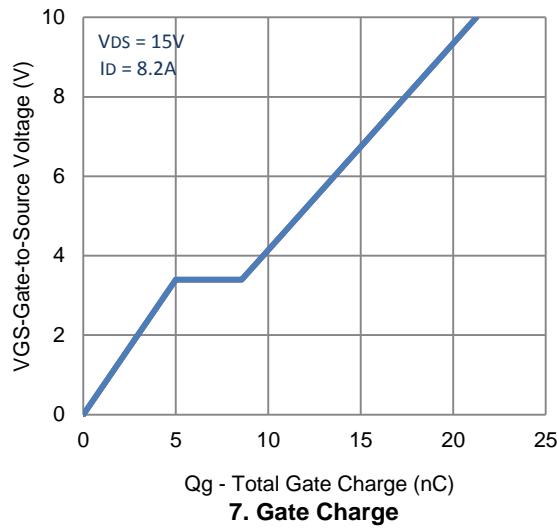


5. Output Characteristics

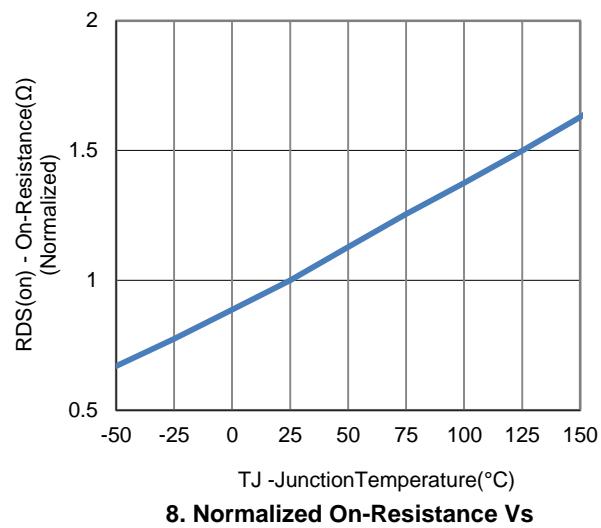


6. Capacitance

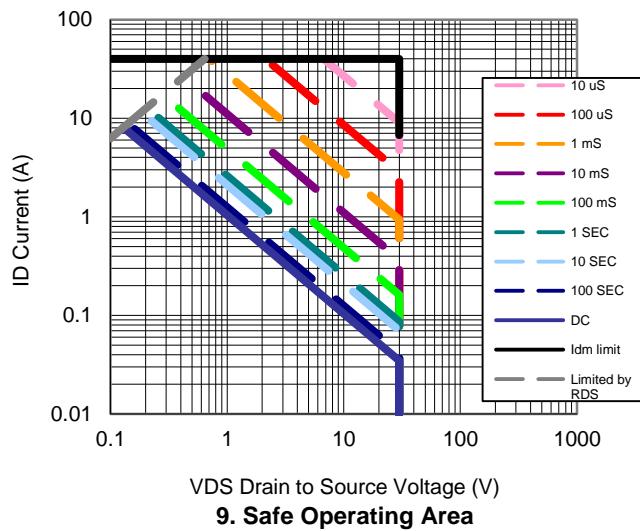
Typical Electrical Characteristics - Q2



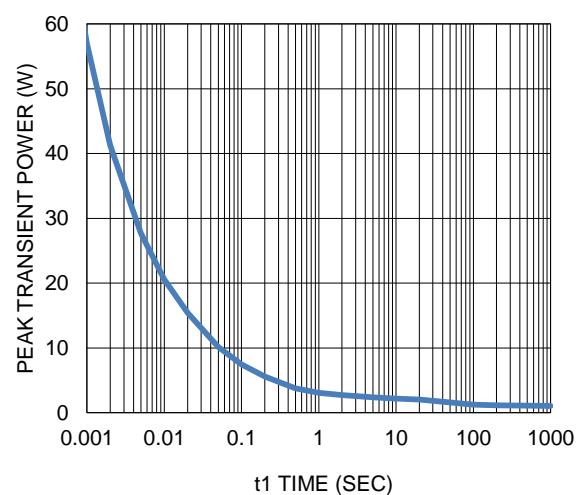
7. Gate Charge



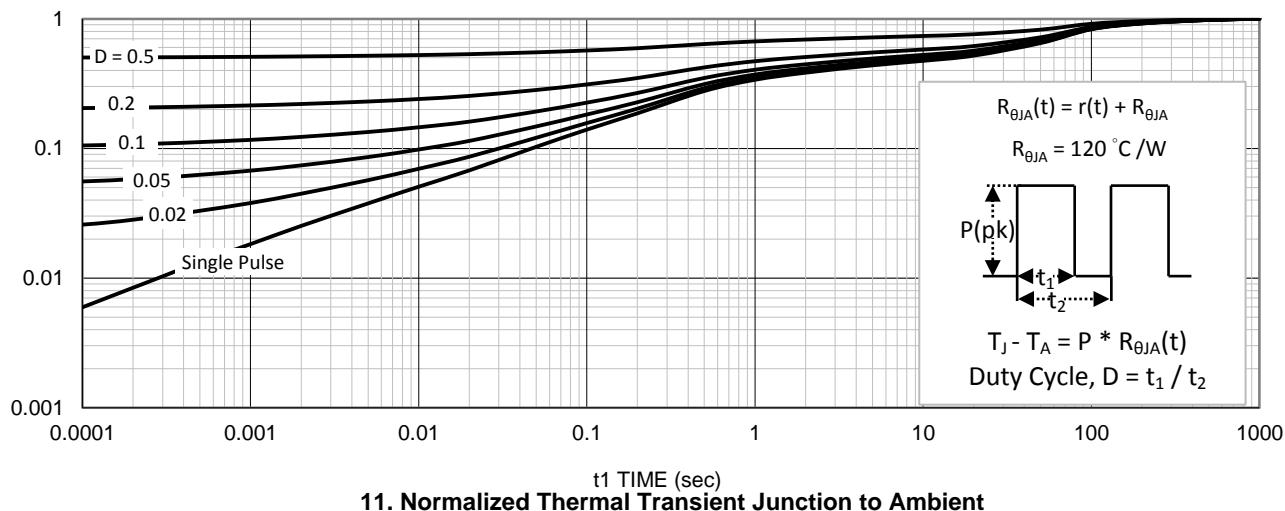
8. Normalized On-Resistance Vs Junction Temperature



9. Safe Operating Area

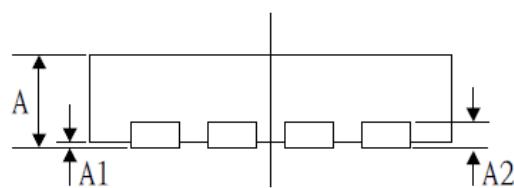
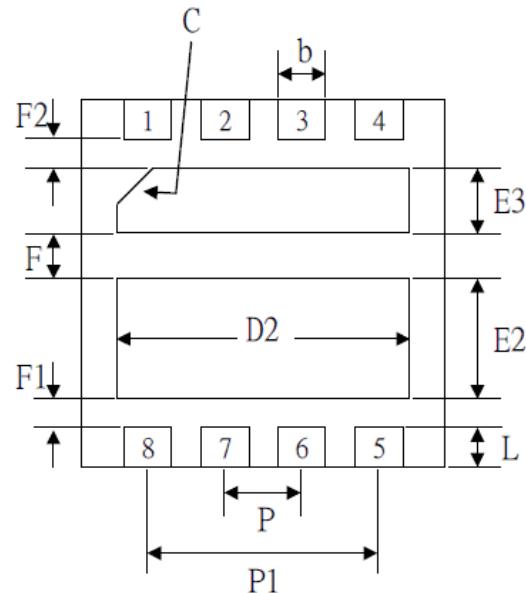
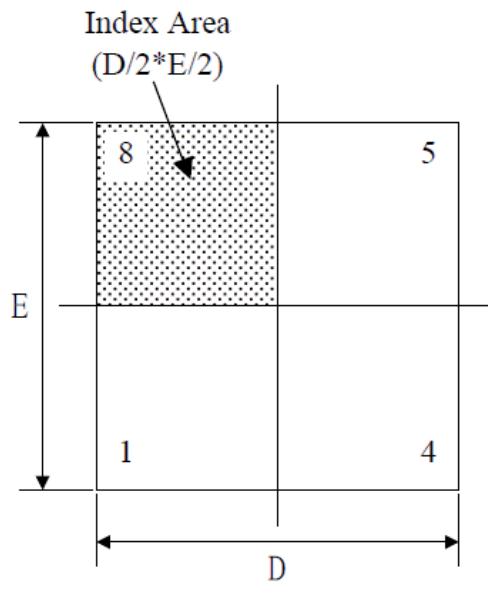


10. Single Pulse Maximum Power Dissipation



11. Normalized Thermal Transient Junction to Ambient

Package Information



Dimension	mm			Dimension	mm		
	MIN.	NOM.	MAX.		MIN.	NOM.	MAX.
A	0.700	0.750	0.800	E2	0.940	0.990	1.100
A1	0.005	0.030	0.050	E3	0.470	0.520	0.570
A2	0.150	0.200	0.250	L	0.270	0.320	0.370
b	0.350	0.400	0.450	P	0.65 BSC		
C	0.30REF			P1	1.95 BSC		
D	2.950	3.000	3.050	F	0.360	0.350	0.460
E	2.950	3.000	3.050	F1/F2	0.200	0.250	0.300
D2	2.350	2.400	2.450				